SCDS167 - MAY 2004

- Member of the Texas Instruments Widebus™ Family
- High-Bandwidth Data Path (Up To 500 MHz[†])
- 5-V Tolerant I/Os with Device Powered Up or Powered Down
- Low and Flat ON-State Resistance (r_{on})
 Characteristics Over Operating Range (r_{on} = 5 Ω Typical)
- Rail-to-Rail Switching on Data I/O Ports
 0-V to 5-V Switching With 3.3-V V_{CC}
 0-V to 3.3-V Switching With 2.5-V V_{CC}
- Bidirectional Data Flow, With Near-Zero Propagation Delay
- Low Input/Output Capacitance Minimizes Loading and Signal Distortion (C_{io(OFF)} = 4 pF Typical)
- Fast Switching Frequency (f_{OE} = 20 MHz Max)
- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (I_{CC} = 1 mA Typical)
- V_{CC} Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0-V to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: PCI Interface, Differential Signal Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating
 - † For additional information regarding the performance characteristics of the CB3Q family, refer to the TI application report, CBT-C, CB3T, and CB3Q Signal-Switch Families, literature number SCDA008.

DGG, DGV, OR DL PACKAGE (TOP VIEW)

	_			
NC	1	\cup	56	1 <u>0E</u>
1A1	2			2OE
1A2	3		54	1B1
1A3	4		53] 1B2
1A4	5		52] 1B3
1A5	6		51] 1B4
1A6	7		50] 1B5
GND	8		49	GND
1A7	9		48] 1B6
1A8	10		47] 1B7
1A9	11		46] 1B8
1A10	12		45] 1B9
1A11	13		44] 1B10
1A12	14		43] 1B11
2A1	15		42]1B12
2A2	16		41	2B1
V _{CC}	17		40	2B2
2A3	18		39	2B3
GND	19		38	GND
2A4	20		37	2B4
2A5	21		36	2B5
2A6	22		35] 2B6
2A7	23		34	2B7
2A8	24		33	2B8
2A9	25		32] 2B9
2A10	26		31	2B10
2A11	27		30	2B11
2A12	28		29	2B12

NC - No internal connection



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description/ordering information

The SN74CB3Q16211 is a high-bandwidth FET bus switch utilizing a charge pump to elevate the gate voltage of the pass transistor, providing a low and flat ON-state resistance (ron). The low and flat ON-state resistance allows for minimal propagation delay and supports rail-to-rail switching on the data input/output (I/O) ports. The device also features low data I/O capacitance to minimize capacitive loading and signal distortion on the data bus. Specifically designed to support high-bandwidth applications, the SN74CB3Q16211 provides an optimized interface solution ideally suited for broadband communications, networking, and data-intensive computing systems.

The SN74CB3Q16211 is organized as two 12-bit bus switches with separate output-enable (1OE, 2OE) inputs. It can be used as two 12-bit bus switches or as one 24-bit bus switch. When \overline{OE} is low, the associated 12-bit bus switch is ON and the A port is connected to the B port, allowing bidirectional data flow between ports. When OE is high, the associated 12-bit bus switch is OFF, and a high-impedance state exists between the A and B

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry prevents damaging current backflow through the device when it is powered down.

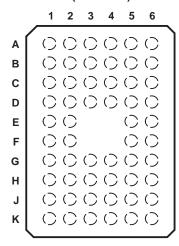
To ensure the high-impedance state during power up or power down, $\overline{\sf OE}$ should be tied to $V_{\sf CC}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION

TA	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	0000 01	Tube	SN74CB3Q16211DL	000010011
	SSOP – DL	Tape and reel	SN74CB3Q16211DLR	CB3Q16211
-40°C to 85°C	TSSOP – DGG	Tape and reel	SN74CB3Q16211DGGR	CB3Q16211
	TVSOP – DGV	Tape and reel	SN74CB3Q16211DGVR	BW211
	VFBGA – GQL	Tape and reel	SN74CB3Q16211GQLR	

[†]Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

GQL PACKAGE (TOP VIEW)



terminal assignments

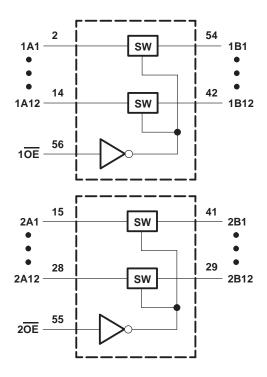
	1	2	3	4	5	6
Α	1A2	1A1	NC	1OE	2OE	1B1
В	1A5	1A4	1A3	1B2	1B3	1B4
С	1A7	GND	1A6	1B5	GND	1B6
D	1A10	1A8	1A9	1B8	1B7	1B9
Е	1A12	1A11			1B10	1B11
F	2A1	2A2			2B1	1B12
G	Vcc	GND	2A3	2B3	GND	2B2
Н	2A4	2A5	2A6	2B6	2B5	2B4
J	2A7	2A8	2A9	2B9	2B8	2B7
K	2A10	2A11	2A12	2B12	2B11	2B10

NC - No internal connection

FUNCTION TABLE (each 12-bit bus switch)

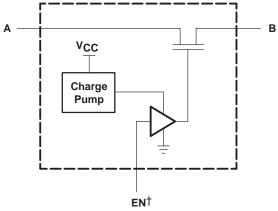
INPUT OE	INPUT/OUTPUT A	FUNCTION
L	В	A port = B port
Н	Z	Disconnect

logic diagram (positive logic)



Pin numbers shown are for the DGG, DGV, and DL packages.

simplified schematic, each FET switch (SW)



[†]EN is the internal enable signal applied to the switch.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} (see Note 1) Control input voltage range, V_{IN} (see Notes 1 ar Switch I/O voltage range, $V_{I/O}$ (see Notes 1, 2, a Control input clamp current, I_{IK} ($V_{IN} < 0$) I/O port clamp current, $I_{I/OK}$ ($V_{I/O} < 0$)	nd 2)and 3)	0.5 V to 7 V 0.5 V to 7 V 50 mA 50 mA
ON-state switch current, I _{I/O} (see Note 4)		±64 mA
Continuous current through V _{CC} or GND terminate	als	±100 mA
Package thermal impedance, θ_{JA} (see Note 5):	DGG package	64°C/W
	DGV package	48°C/W
	DL package	56°C/W
	GQL package	42°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltages are with respect to ground unless otherwise specified.
 - 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 3. VI and VO are used to denote specific conditions for VI/O.
 - 4. II and IO are used to denote specific conditions for II/O.
 - 5. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		ı	MIN	MAX	UNIT	
Vcc	Supply voltage		2.3	3.6	V	
.,	$V_{CC} = 2.3 \text{ V to } 2$.7 V	1.7	5.5	.,	
VIH	High-level control input voltage V _{CC} = 2.7 V to 3	.6 V	2	5.5	5.5 V	
.,	V _{CC} = 2.3 V to 2.7 V		0	0.7	.,	
V _{IL}	Low-level control input voltage $V_{CC} = 2.7 \text{ V to 3}$.6 V	0	0.8	V	
V _{I/O}	Data input/output voltage		0	5.5	V	
TA					°C	

NOTE 6: All unused control inputs of the device must be held at VCC or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAI	PARAMETER TEST CONDITIONS			IS	MIN	TYP [†]	MAX	UNIT
VIK		V _{CC} = 3.6 V,	$I_{I} = -18 \text{ mA}$				-1.8	V
I _{IN}	Control inputs	V _{CC} = 3.6 V,	$V_{IN} = 0 \text{ to } 5.5 \text{ V}$				±1	μΑ
l _{OZ} ‡		V _{CC} = 3.6 V,	$V_O = 0 \text{ to } 5.5 \text{ V},$ $V_I = 0,$	Switch OFF, V _{IN} = V _{CC} or GND			±1	μΑ
l _{off}		$V_{CC} = 0$,	$V_0 = 0 \text{ to } 5.5 \text{ V},$	V _I = 0			1	μΑ
ICC		V _{CC} = 3.6 V,	I _{I/O} = 0, Switch ON or OFF,	$V_{IN} = V_{CC}$ or GND		1	3	mA
∆l _{CC} §	Control inputs	V _{CC} = 3.6 V,	One input at 3 V,	Other inputs at V _{CC} or GND			30	μΑ
ICCD¶	Per control input	V _{CC} = 3.6 V,	A and B ports open, Control input switching at 50% duty cycle			0.15	0.25	mA/ MHz
C _{in}	Control inputs	V _{CC} = 3.3 V,	V _{IN} = 5.5 V, 3.3 V, or	0		3.5	5	pF
C _{io(OFF}	=)	V _{CC} = 3.3 V,	Switch OFF, V _{IN} = V _{CC} or GND,	V _{I/O} = 5.5 V, 3.3 V, or 0		4	5	pF
C _{io(ON)})	V _{CC} = 3.3 V,	Switch ON, V _{IN} = V _{CC} or GND,	V _{I/O} = 5.5 V, 3.3 V, or 0		10	12.5	pF
#		V _{CC} = 2.3 V,	$V_{I} = 0,$	I _O = 30 mA		5	8	
		TYP at $V_{CC} = 2.5 \text{ V}$	V _I = 1.7 V,	$I_{O} = -15 \text{ mA}$		5	9	Ω
r _{on} #		Vac - 2 V	V _I = 0,	I _O = 30 mA		5	6.5	22
		VCC = 3 V	V _I = 2.4 V,	I _O = -15 mA		5	8	

NOTE 7: V_{IN} and I_{IN} refer to control inputs. V_I, V_O, I_I, and I_O refer to data pins.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	TO	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 3.3 V ± 0.3 V		UNIT	
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX		
fOE	ŌĒ	A or B		10		20	MHz	
t _{pd} ☆	A or B	B or A		0.15		0.25	ns	
t _{en}	ŌE	A or B	1.5	8	1.5	8	ns	
^t dis	ŌĒ	A or B	1	7.5	1	7.5	ns	

Il Maximum switching frequency for control input ($V_O > V_{CC}$, $V_I = 5$ V, $R_L \ge 1$ M Ω , $C_L = 0$)



 $^{^{\}dagger}$ All typical values are at VCC = 3.3 V (unless otherwise noted), TA = 25 $^{\circ}$ C.

[‡] For I/O ports, the parameter I_{OZ} includes the input leakage current.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

[¶] This parameter specifies the dynamic power-supply current associated with the operating frequency of a single control input (see Figure 2).

[#] Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

^{*}The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

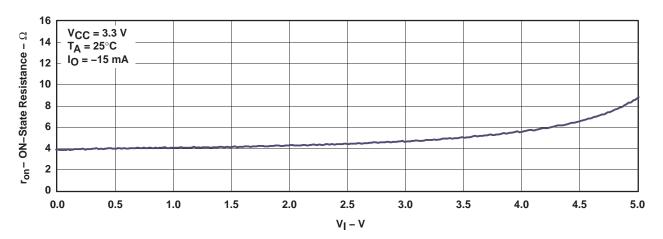


Figure 1. Typical r_{on} vs V_{I}

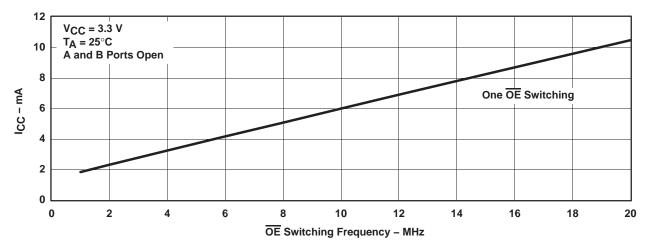
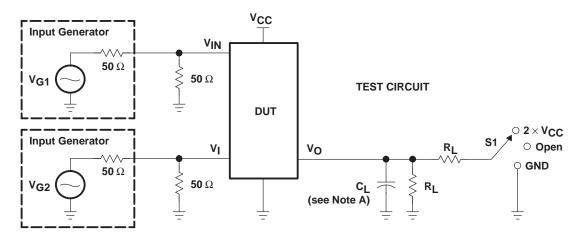


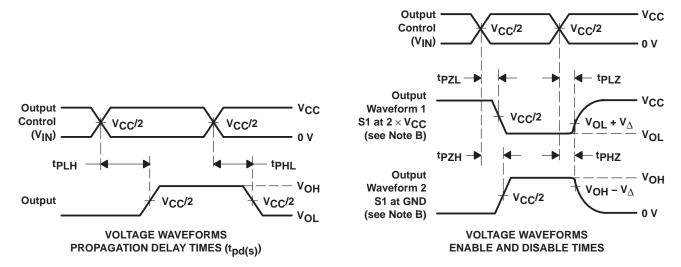
Figure 2. Typical I_{CC} vs \overline{OE} Switching Frequency



PARAMETER MEASUREMENT INFORMATION



TEST	VCC	S1	RL	VI	CL	${f v}_{\Delta}$
tpd(s)	2.5 V \pm 0.2 V	Open	500 Ω	V _{CC} or GND	30 pF	
pu(3)	3.3 V \pm 0.3 V	Open	500 Ω	V _{CC} or GND	50 pF	
tplz/tpzl	2.5 V \pm 0.2 V	2×V _{CC}	500 Ω	GND	30 pF	0.15 V
'PLZ''PZL	3.3 V \pm 0.3 V	2×VCC	500 Ω	GND	50 pF	0.3 V
4/4	2.5 V ± 0.2 V	GND	500 Ω	VCC	30 pF	0.15 V
tPHZ/tPZH	3.3 V \pm 0.3 V	GND	500 Ω	VCC	50 pF	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \Omega$, $t_f \leq 2.5 \text{ ns.}$
- D. The outputs are measured one at a time, with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Test Circuit and Voltage Waveforms



DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

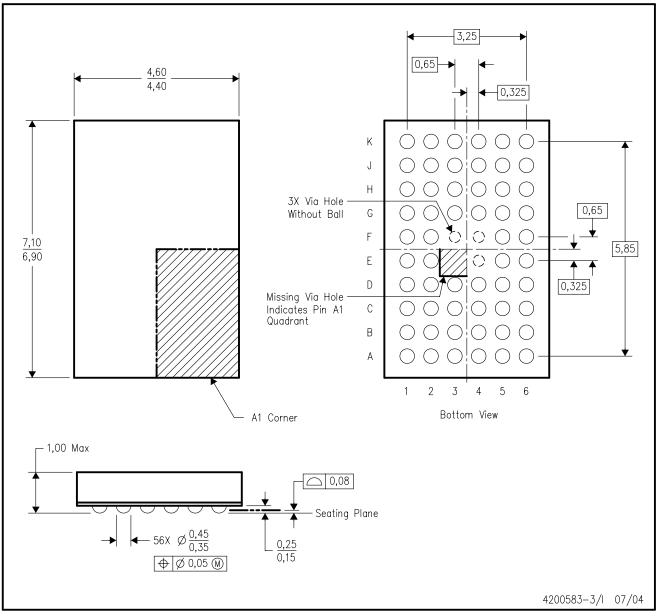
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



DL (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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